Intel - EP4CE15F17I7N Datasheet





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Details

Product Status	Active
Number of LABs/CLBs	963
Number of Logic Elements/Cells	15408
Total RAM Bits	516096
Number of I/O	165
Number of Gates	-
Voltage - Supply	1.15V ~ 1.25V
Mounting Type	Surface Mount
Operating Temperature	-40°C ~ 100°C (TJ)
Package / Case	256-LBGA
Supplier Device Package	256-FBGA (17x17)
Purchase URL	https://www.e-xfl.com/product-detail/intel/ep4ce15f17i7n

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Table 5–2. GCLK Network Connections for EP4CGX30, EP4CGX50, EP4CGX75, EP4CGX110, and EP4CGX150 Devices ^{(1), (2)} (Part 4 of 4)

GCLK Network Clock														GCI	LK Ne	etwo	rks													
Sources	0	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	17	18	19	20	21	22	23	24	25	26	27	28	29
DPCLK17		_			—		_	—	—	—	$\left - \right $	—	_	_	_	_	—	_	-	\checkmark	_	—			_	_	—	_	—	—

Notes to Table 5-2:

(1) EP4CGX30 information in this table refers to only EP4CGX30 device in F484 package.

(2) PLL_1, PLL_2, PLL_3, and PLL_4 are general purpose PLLs while PLL_5, PLL_6, PLL_7, and PLL_8 are multipurpose PLLs.

(3) PLL_7 and PLL_8 are not available in EP4CXGX30, EP4CGX50, EP4CGX75, EP4CGX110, and EP4CGX150 devices in F484 package.

GCLK Network Clock	GCLK Networks																			
Sources	0	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	17	18	19
CLK1	—	\checkmark	\checkmark	—	—	—	—	—	—	—	—	—	—	—	—	—	—	—	—	—
CLK2/DIFFCLK_1p		\checkmark		\checkmark	\checkmark					_								_	-	—
CLK3/DIFFCLK_1n	\checkmark			\checkmark						_								_	_	—
CLK4/DIFFCLK_2p	-	_	-	-	-	\checkmark	-	>	-	<										—
CLK5/DIFFCLK_2n							\checkmark	\checkmark			—	—	—	—	—		—			—
CLK6/DIFFCLK_3p							~		\checkmark	\checkmark								_	_	—
CLK7/DIFFCLK_3n	-	_	-	-	-	\checkmark	-		\checkmark	Ι										—
CLK8/DIFFCLK_5n (2)								—			\checkmark	_	\checkmark	_	\checkmark		_	Ι	Ι	—
CLK9/DIFFCLK_5p (2)								—			—	\checkmark	\checkmark	—	—		—			—
CLK10/DIFFCLK_4n (2)	_	_	_	_	—	_	—	_	_	_		~	_	~	~	_		_	_	—
CLK11/DIFFCLK_4p (2)	_	_	_	_	_	_	_	_	_	_	~	_	_	~	_	_	_	_	_	
CLK12/DIFFCLK_7n (2)	_		_	_	_	_	_		_	_	_			_		~	_	~	_	~
CLK13/DIFFCLK_7p (2)					_	_	_	_		_	_	_	_	_	_	_	\checkmark	~	_	
CLK14/DIFFCLK_6n (2)		_	—		_		_	_	—	_		_	_				~	_	~	~

Table 5-3. GCLK Network Connections for Cyclone IV E Devices (1) (Part 1 of 3)

Figure 5–14 shows a waveform example of the phase relationship of the PLL clocks in this mode.



Figure 5-14. Phase Relationship Between PLL Clocks in Normal Mode

Note to Figure 5-14:

(1) The external clock output can lead or lag the PLL internal clock signals.

Zero Delay Buffer Mode

In zero delay buffer (ZDB) mode, the external clock output pin is phase-aligned with the clock input pin for zero delay through the device. When using this mode, use the same I/O standard on the input clock and output clocks to guarantee clock alignment at the input and output pins.

Figure 5–15 shows an example waveform of the phase relationship of the PLL clocks in ZDB mode.





Programmable Bandwidth

The PLL bandwidth is the measure of the PLL's ability to track the input clock and its associated jitter. PLLs of Cyclone IV devices provide advanced control of the PLL bandwidth using the programmable characteristics of the PLL loop, including loop filter and charge pump. The closed-loop gain 3-dB frequency in the PLL determines the PLL bandwidth. The bandwidth is approximately the unity gain point for open loop PLL response.

Phase Shift Implementation

Phase shift is used to implement a robust solution for clock delays in Cyclone IV devices. Phase shift is implemented with a combination of the VCO phase output and the counter starting time. The VCO phase output and counter starting time are the most accurate methods of inserting delays, because they are based only on counter settings that are independent of process, voltage, and temperature.

You can phase shift the output clocks from the PLLs of Cyclone IV devices in one of two ways:

- Fine resolution using VCO phase taps
- Coarse resolution using counter starting time

Fine resolution phase shifts are implemented by allowing any of the output counters (C[4..0]) or the M counter to use any of the eight phases of the VCO as the reference clock. This allows you to adjust the delay time with a fine resolution.

Equation 5–1 shows the minimum delay time that you can insert using this method.

Equation 5–1. Fine Resolution Phase Shift

 $f_{\text{fine}} = \frac{T_{VCO}}{8} = \frac{1}{8f_{VCO}} = \frac{N}{8Mf_{REF}}$

in which f_{REF} is the input reference clock frequency.

For example, if f_{REF} is 100 MHz, N = 1, and M = 8, then f_{VCO} = 800 MHz, and Φ_{fine} = 156.25 ps. The PLL operating frequency defines this phase shift, a value that depends on reference clock frequency and counter settings.

Coarse resolution phase shifts are implemented by delaying the start of the counters for a predetermined number of counter clocks. Equation 5–2 shows the coarse phase shift.

Equation 5–2. Coarse Resolution Phase Shift

 $\Phi_{\text{coarse}} = \frac{C-1}{f_{VCO}} = \frac{(C-1)N}{Mf_{REF}}$

C is the count value set for the counter delay time (this is the initial setting in the PLL usage section of the compilation report in the Quartus II software). If the initial value is 1, $C - 1 = 0^{\circ}$ phase shift.

Figure 7–1 shows the block diagram of a typical external memory interface data path in Cyclone IV devices.





Note to Figure 7-1:

(1) All clocks shown here are global clocks.

To For more information about implementing complete external memory interfaces, refer to the *External Memory Interface Handbook*.

Cyclone IV Devices Memory Interfaces Pin Support

Cyclone IV devices use data (DQ), data strobe (DQS), clock, command, and address pins to interface with external memory. Some memory interfaces use the data mask (DM) or byte write select (BWS#) pins to enable data masking. This section describes how Cyclone IV devices support all these different pins.

C For more information about pin utilization, refer to *Volume 2: Device, Pin, and Board Layout Guidelines* of the *External Memory Interface Handbook.*

Data and Data Clock/Strobe Pins

Cyclone IV data pins for external memory interfaces are called D for write data, Q for read data, or DQ for shared read and write data pins. The read-data strobes or read clocks are called DQS pins. Cyclone IV devices support both bidirectional data strobes and unidirectional read clocks. Depending on the external memory standard, the DQ and DQS are bidirectional signals (in DDR2 and DDR SDRAM) or unidirectional signals (in QDR II SRAM). Connect the bidirectional DQ data signals to the same Cyclone IV devices DQ pins. For unidirectional D or Q signals, connect the read-data signals to a group of DQ pins and the write-data signals to a different group of DQ pins.

In QDR II SRAM, the Q read-data group must be placed at a different V_{REF} bank location from the D write-data group, command, or address pins.

DDR Output Registers

A dedicated write DDIO block is implemented in the DDR output and output enable paths.

Figure 7–8 shows how a Cyclone IV dedicated write DDIO block is implemented in the I/O element (IOE) registers.

Figure 7–8. Cyclone IV Dedicated Write DDIO



The two DDR output registers are located in the I/O element (IOE) block. Two serial data streams routed through datain_l and datain_h, are fed into two registers, output register Ao and output register Bo, respectively, on the same clock edge. The output from output register Ao is captured on the falling edge of the clock, while the output from output register Bo is captured on the rising edge of the clock. The registered outputs are multiplexed by the common clock to drive the DDR output pin at twice the data rate.

The DDR output enable path has a similar structure to the DDR output path in the IOE block. The second output enable register provides the write preamble for the DQS strobe in DDR external memory interfaces. This active-low output enable register extends the high-impedance state of the pin by half a clock cycle to provide the external memory's DQS write preamble time specification.

To For more information about Cyclone IV IOE registers, refer to the *Cyclone IV Device I/O Features* chapter.

Section III. System Integration

This section includes the following chapters:

- Chapter 8, Configuration and Remote System Upgrades in Cyclone IV Devices
- Chapter 9, SEU Mitigation in Cyclone IV Devices
- Chapter 10, JTAG Boundary-Scan Testing for Cyclone IV Devices
- Chapter 11, Power Requirements for Cyclone IV Devices

Revision History

Refer to each chapter for its own specific revision history. For information on when each chapter was updated, refer to the Chapter Revision Dates section, which appears in the complete handbook.

Power-On Reset (POR) Circuit

The POR circuit keeps the device in reset state until the power supply voltage levels have stabilized during device power up. After device power up, the device does not release nSTATUS until V_{CCINT}, V_{CCA}, and V_{CCIO} (for I/O banks in which the configuration and JTAG pins reside) are above the POR trip point of the device. V_{CCINT} and V_{CCA} are monitored for brown-out conditions after device power up.

 V_{CCA} is the analog power to the phase-locked loop (PLL).

In some applications, it is necessary for a device to wake up very quickly to begin operation. Cyclone IV devices offer the fast POR time option to support fast wake-up time applications. The fast POR time option has stricter power-up requirements when compared with the standard POR time option. You can select either the fast option or the standard POR option with the MSEL pin settings.

- IF your system exceeds the fast or standard POR time, you must hold nCONFIG low until all the power supplies are stable.
 - For more information about the POR specifications, refer to the *Cyclone IV Device Datasheet*.
- **To** For more information about the wake-up time and POR circuit, refer to the *Power Requirements for Cyclone IV Devices* chapter.

Configuration File Size

Table 8–2 lists the approximate uncompressed configuration file sizes for Cyclone IV devices. To calculate the amount of storage space required for multiple device configurations, add the file size of each device together.

	Device	Data Size (bits)
	EP4CE6	2,944,088
	EP4CE10	2,944,088
	EP4CE15	4,086,848
	EP4CE22	5,748,552
Cyclone IV E	EP4CE30	9,534,304
	EP4CE40	9,534,304
	EP4CE55	14,889,560
	EP4CE75	19,965,752
	EP4CE115	28,571,696

Table 8–2. Uncompressed Raw Binary File (.rbf) Sizes for Cyclone IV Devices (Part 1 of 2)

For more information about the operation of the Micron P30 Parallel NOR and P33 Parallel NOR flash memories, search for the keyword "P30" or "P33" on the Micron website (www.micron.com) to obtain the P30 or P33 family datasheet.

Single-Device AP Configuration

The following groups of interface pins are supported in Micron P30 and P33 flash memories:

- Control pins
- Address pins
- Data pins

The following control signals are from the supported parallel flash memories:

- CLK
- active-low reset (RST#)
- active-low chip enable (CE#)
- active-low output enable (OE#)
- active-low address valid (ADV#)
- active-low write enable (WE#)

The supported parallel flash memories output a control signal (WAIT) to Cyclone IV E devices to indicate when synchronous data is ready on the data bus. Cyclone IV E devices have a 24-bit address bus connecting to the address bus (A[24:1]) of the flash memory. A 16-bit bidirectional data bus (DATA[15..0]) provides data transfer between the Cyclone IV E device and the flash memory.

The following control signals are from the Cyclone IV E device to flash memory:

- DCLK
- active-low hard rest (nRESET)
- active-low chip enable (FLASH_nCE)
- active-low output enable for the DATA [15..0] bus and WAIT pin (nOE)
- active-low address valid signal and is used to write data into the flash (nAVD)
- active-low write enable and is used to write data into the flash (nWE)

 Bit reversal—reverses the transmit bit order from LSB-to-MSB (default) to MSB-to-LSB at the input to the serializer. For example, input data to serializer D[7..0] is rewired to D[0..7] for 8-bit data width, and D[9..0] is rewired to D[0..9] for 10-bit data width. Figure 1–10 shows the transmitter bit reversal feature.



Figure 1–10. Transmitter Bit Reversal Operation in Basic Single-Width Mode

- Input bit-flip—reverses the bit order at a byte level at the input of the transmitter phase compensation FIFO. For example, if the 16-bit parallel transmitter data at the tx_datain port is '10111100 10101101' (16'hBCAD), selecting this option reverses the input data to the transmitter phase compensation FIFO to '00111101 10110101' (16'h3DB5).
- Bit-slip control—delays the data transmission by a number of specified bits to the serializer with the tx_bitslipboundaryselect port. For usage details, refer to the "Transmit Bit-Slip Control" on page 1–76.

Serializer

The serializer converts the low-speed parallel 8-bit or 10-bit data from the transmitter PCS to high-speed serial data for the transmitter output buffer. The serializer operates with a high-speed clock at half of the serial data rate. The serializer transmission sequence is LSB to MSB.

In a DC-coupled link, the transmitter DC common mode voltage is seen unblocked at the receiver input buffer as shown in Figure 1–13. The link common mode voltage depends on the transmitter common mode voltage and the receiver common mode voltage. When using the receiver OCT and on-chip biasing circuitry in a DC coupled link, you must ensure the transmitter common mode voltage is compatible with the receiver common mode requirements. If you disable the OCT, you must terminate and bias the receiver externally and ensure compatibility between the transmitter and the receiver common mode voltage.





Figure 1–14 shows the receiver input buffer block diagram.





The receiver input buffers support the following features:

Cyclone IV GX transceivers do not have built-in support for some PCS functions such as auto-negotiation state machine, collision-detect, and carrier-sense. If required, you must implement these functions in a user logic or external circuits.

The 1000 Base-X PHY is defined by IEEE 802.3 standard as an intermediate or transition layer that interfaces various physical media with the media access control (MAC) in a GbE system. The 1000 Base-X PHY, which has a physical interface data rate of 1.25 Gbps consists of the PCS, PMA, and physical media dependent (PMD) layers. Figure 1–54 shows the 1000 Base-X PHY in LAN layers.



Figure 1–54. 1000 Base-X PHY in a GbE OSI Reference Model

Notes to Figure 1-54:

- (1) CSMA/CD = Carrier-Sense Multiple Access with Collision Detection
- (2) GMII = gigabit medium independent interface

Transceiver Top-Level Port Lists

Table 1–26 through Table 1–29 provide descriptions of the ports available when instantiating a transceiver using the ALTGX megafunction. The ALTGX megafunction requires a relatively small number of signals. There are also a large number of optional signals that facilitate debugging by providing information about the state of the transceiver.

Transmitter Only Channel

This configuration contains only a transmitter channel. If you create a **Transmitter Only** instance in the ALTGX MegaWizard Plug-In Manager, use the same reset sequence shown in Figure 2–3 on page 2–7.

Receiver Only Channel—Receiver CDR in Automatic Lock Mode

This configuration contains only a receiver channel. If you create a **Receiver Only** instance in the ALTGX MegaWizard Plug-In Manager with the receiver CDR in automatic lock mode, use the reset sequence shown in Figure 2–6.

Figure 2–6. Sample Reset Sequence of Receiver Only Channel—Receiver CDR in Automatic Lock Mode



Notes to Figure 2-6:

- (1) For t_{LTD Auto} duration, refer to the *Cyclone IV Device Datasheet* chapter.
- (2) The busy signal is asserted and deasserted only during initial power up when offset cancellation occurs. In subsequent reset sequences, the busy signal is asserted and deasserted only if there is a read or write operation to the ALTGX_RECONFIG megafunction.

As shown in Figure 2–6, perform the following reset procedure for the receiver in CDR automatic lock mode:

- 1. After power up, wait for the busy signal to be deasserted.
- 2. Keep the rx_digitalreset and rx_analogreset signals asserted during this time period.
- 3. After the busy signal is deasserted, wait for another two parallel clock cycles, then deassert the rx analogreset signal.
- 4. Wait for the rx_freqlocked signal to go high.
- 5. When rx_freqlocked goes high (marker 3), from that point onwards, wait for at least t_{LTD_Auto}, then de-assert the rx_digitalreset signal (marker 4). At this point, the receiver is ready to receive data.

In PCIe mode simulation, you must assert the tx_forceelecidle signal for at least one parallel clock cycle before transmitting normal data for correct simulation behavior.

Reference Information

For more information about some useful reference terms used in this chapter, refer to the links listed in Table 2–7.

Terms Used in this Chapter	Useful Reference Points
Automatic Lock Mode	page 2–8
Bonded channel configuration	page 2–6
busy	page 2–3
Dynamic Reconfiguration Reset Sequences	page 2–19
gxb_powerdown	page 2–3
LTD	page 2–6
LTR	page 2–6
Manual Lock Mode	page 2–9
Non-Bonded channel configuration	page 2–10
PCIe	page 2–17
pll_locked	page 2–3
pll_areset	page 2–3
rx_analogreset	page 2–2
rx_digitalreset	page 2–2
rx_freqlocked	page 2–3
tx_digitalreset	page 2–2

Table 2–7. Reference Information

3. Cyclone IV Dynamic Reconfiguration

Cyclone[®] IV GX transceivers allow you to dynamically reconfigure different portions of the transceivers without powering down any part of the device. This chapter describes and provides examples about the different modes available for dynamic reconfiguration.

You can use the ALTGX_RECONFIG and ALTPLL_RECONFIG controller instance to reconfigure the physical medium attachment (PMA) controls, physical coding sublayer (PCS), multipurpose phase locked loops (PLLs), and general purpose PLLs.

This chapter contains the following sections:

- "Glossary of Terms" on page 3–1
- "Dynamic Reconfiguration Controller Architecture" on page 3–2
- "Dynamic Reconfiguration Modes" on page 3–12
- "Error Indication During Dynamic Reconfiguration" on page 3–36
- "Functional Simulation of the Dynamic Reconfiguration Process" on page 3–37

Glossary of Terms

Table 3–1 lists the terms used in this chapter:

Term	Description
ALTGX_RECONFIG Instance	Dynamic reconfiguration controller instance generated by the ALTGX_RECONFIG MegaWizard [™] Plug-In Manager.
ALTGX Instance	Transceiver instance generated by the ALTGX MegaWizard Plug-In Manager.
ALTPLL_RECONFIG Instance	Dynamic PLL reconfiguration controller instance generated by the ALTPLL_RECONFIG Megawizard Plug-In Manager
Logical Channel Addressing	Used whenever the concept of logical channel addressing is explained. This term does not refer to the logical_channel_address port available in the ALTGX_RECONFIG MegaWizard Plug-In Manager.

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Option 1: Share a Single Transmitter Core Clock Between Receivers

- Enable this option if you want tx_clkout of the first channel (channel 0) of the transceiver block to provide the read clock to the Receive Phase Compensation FIFOs of the remaining receiver channels in the transceiver block.
- This option is typically enabled when all the channels of a transceiver block are in a Basic or Protocol configuration with rate matching enabled and are reconfigured to another Basic or Protocol configuration with rate matching enabled.

Figure 3–13 shows the sharing of channel 0's tx_clkout between all four channels of a transceiver block.





Visual Cue	Meaning					
	Indicates signal, port, register, bit, block, and primitive names. For example, data1, tdi, and input. The suffix n denotes an active-low signal. For example, resetn.					
Courier type	Indicates command line commands and anything that must be typed exactly as it appears. For example, c:\qdesigns\tutorial\chiptrip.gdf.					
	Iso indicates sections of an actual file, such as a Report File, references to parts of iles (for example, the AHDL keyword SUBDESIGN), and logic function names (for example, TRI).					
4	An angled arrow instructs you to press the Enter key.					
1., 2., 3., and a., b., c., and so on	Numbered steps indicate a list of items when the sequence of the items is important, such as the steps listed in a procedure.					
	Bullets indicate a list of items when the sequence of the items is not important.					
LP	The hand points to information that requires special attention.					
(?)	The question mark directs you to a software help system with related information.					
	The feet direct you to another document or website with related information.					
[], , , , , , , , , , , , , , , , , , ,	The multimedia icon directs you to a related multimedia presentation.					
CAUTION	A caution calls attention to a condition or possible situation that can damage or destroy the product or your work.					
WARNING	A warning calls attention to a condition or possible situation that can cause you injury.					
	The envelope links to the Email Subscription Management Center page of the Altera website, where you can sign up to receive update notifications for Altera documents.					

A DC signal is equivalent to 100% duty cycle. For example, a signal that overshoots to 4.3 V can only be at 4.3 V for 65% over the lifetime of the device; for a device lifetime of 10 years, this amounts to 65/10ths of a year.

Symbol	Parameter	Condition (V)	Overshoot Duration as % of High Time	Unit																					
		V ₁ = 4.20	100	%																					
		V ₁ = 4.25	98	%																					
		V ₁ = 4.30	65	%																					
	AC Input Voltage	AC Input Voltage	V ₁ = 4.35	43	%																				
Vi			AC Input Voltage	AC Input Voltage	AC Input Voltage	AC Input Voltage	AC Input Voltage	AC Input Voltage	AC Input	AC Input Voltage	AC INPUT	AC Input Voltage	Voltage	V ₁ = 4.40	29	%									
								V ₁ = 4.45	20	%															
		$V_1 = 4.50$	13	%																					
		V ₁ = 4.55	9	%																					
		$V_1 = 4.60$	6	%																					

Table 1–2. Maximum Allowed Overshoot During Transitions over a 10-Year Time Frame for Cyclone IV Devices

Figure 1–1 shows the methodology to determine the overshoot duration. The overshoot voltage is shown in red and is present on the input pin of the Cyclone IV device at over 4.3 V but below 4.4 V. From Table 1–2, for an overshoot of 4.3 V, the percentage of high time for the overshoot can be as high as 65% over a 10-year period. Percentage of high time is calculated as ([delta T]/T) × 100. This 10-year period assumes that the device is always turned on with 100% I/O toggle rate and 50% duty cycle signal. For lower I/O toggle rates and situations in which the device is in an idle state, lifetimes are increased.





Example 1–1 shows how to calculate the change of 50- Ω I/O impedance from 25°C at 3.0 V to 85°C at 3.15 V.

Example 1–1. Impedance Change

$$\begin{split} \Delta R_V &= (3.15-3) \times 1000 \times -0.026 = -3.83 \\ \Delta R_T &= (85-25) \times 0.262 = 15.72 \\ \text{Because } \Delta R_V \text{ is negative,} \\ MF_V &= 1 \ / \ (3.83/100 + 1) = 0.963 \\ \text{Because } \Delta R_T \text{ is positive,} \\ MF_T &= 15.72/100 + 1 = 1.157 \\ MF &= 0.963 \times 1.157 = 1.114 \\ R_{\text{final}} &= 50 \times 1.114 = 55.71 \ \Omega \end{split}$$

Pin Capacitance

Table 1–11 lists the pin capacitance for Cyclone IV devices.

Table 1–11.	Pin Cap	acitance for	Cvclone I	V Devices	(1)
	i ili oup		0,0101101	I DUTIOUS	

Symbol	Parameter	Typical – Quad Flat Pack (QFP)	Typical – Quad Flat No Leads (QFN)	Typical – Ball-Grid Array (BGA)	Unit
CIOTB	Input capacitance on top and bottom I/O pins	7	7	6	pF
C _{IOLR}	Input capacitance on right I/O pins	7	7	5	pF
C_{LVDSLR}	Input capacitance on right I/O pins with dedicated LVDS output	8	8	7	pF
C _{VREFLR}	Input capacitance on right dual-purpose ${\tt VREF}$ pin when used as $V_{\sf REF}$ or user I/O pin	21	21	21	pF
C _{VREFTB}	Input capacitance on top and bottom dual-purpose \mathtt{VREF} pin when used as $V_{\textrm{REF}}$ or user I/O pin	23 <i>(3)</i>	23	23	pF
C _{CLKTB}	Input capacitance on top and bottom dedicated clock input pins	7	7	6	pF
C _{CLKLR}	Input capacitance on right dedicated clock input pins	6	6	5	pF

Notes to Table 1-11:

(1) The pin capacitance applies to FBGA, UBGA, and MBGA packages.

(2) When you use the vref pin as a regular input or output, you can expect a reduced performance of toggle rate and t_{CO} because of higher pin capacitance.

(3) C_{VREFTB} for the EP4CE22 device is 30 pF.